

## Listing of Claims

1. (Currently Amended) A semiconductor memory device, comprising:  
an integrated circuit (IC) memory chip comprising an integrated memory circuit and a plurality of address pins, wherein the integrated memory circuit comprises;  
a memory cell array;  
a data buffer for processing data read from or written to the memory cell array; and  
a data width control circuit for selectively controlling a data width of the data buffer in response to one or more address bits of an external address signal applied to one or more address pins of the IC memory chip, wherein the data width control circuit comprises:  
a decoder for decoding the one or more address bits of external address signal in response to a data access command to generate a first control signal; and  
a data buffer controller, responsive to the first control signal, to generate a second control signal for controlling the data width of the data buffer.  
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2. (Canceled)
3. (Original) The device of claim 1, wherein the data width control circuit selectively controls the data width of the data buffer by generating a control signal that masks or unmasks one or more bits of the data buffer.
4. (Original) The device of claim 3, wherein a masked bit is prevented from being input to the memory cell array from the data buffer.
5. (Original) The device of claim 3, wherein a masked bit is prevented from being output from the data buffer.
6. (Original) The device of claim 1, wherein the data buffer has a width of  $n$  bits and wherein the data width of the data buffer is selectively controlled to be  $n$  bits or less.

7. (Currently Amended) The device of claim 1 2, wherein the decoder comprises:  
a switching circuit; and

a logic circuit, wherein the switching circuit is response to the data access command to pass the one or more address bits of the external address signal to the logic circuit and wherein the logic circuit processes the external command to generate the first control signal based on the external command.

8. (Previously Presented) The device of claim 7, wherein the logic circuit comprises a plurality of parallel connected AND gates that receive the one or more bits of the external address signal, and wherein the first control signal comprises a plural bit signal comprised of the output signals from the AND gates.

9. (Original) The device of claim 8, wherein the data buffer controller comprises:  
a switching circuit comprising a plurality of parallel connected switches, wherein each switch receives the data access command, and wherein one or more switches are selectively activated in response to the first control signal to generate the second control signal, the second control signal comprise a plural bit signal comprised of the output signals of the switches.

10. (Currently Amended) A semiconductor memory device, comprising:  
an integrated circuit (IC) memory chip comprising an integrated memory circuit and a plurality of address pins, wherein the integrated memory circuit comprises;  
a memory cell array;  
a data output buffer for outputting data read from the memory cell array;  
a data input data buffer for inputting data to be written to the memory cell array; and  
a data width control circuit for selectively controlling a data width of the data output buffer or the data input buffer in response to one or more address bits of an external address signal applied to one or more of the address pins of the IC memory chip, wherein the data width control circuit comprises:  
a decoder which is activated in response to a read command signal or write command signal to decode the one or more address bits of the external address to generate a first control signal;

a data input buffer controller which is activated in response to the write command signal to generate a second control signal for controlling the data width of the data input buffer based on the first control signal; and

a data output buffer controller which is activated in response to the read command signal to generate a second control signal for controlling the data width of the data output buffer based on the first control signal.

11. (Canceled)

12. (Original) The device of claim 10, wherein the data width control circuit selectively controls the data width of the data input buffer or data output buffer by generating a control signal that masks or unmasks one or more bits of the data buffer.

13. (Original) The device of claim 12, wherein a masked bit is prevented from being input to the memory cell array from the data input data buffer.

14. (Original) The device of claim 12, wherein a masked bit is prevented from being output from the data output buffer.

15. (Original) The device of claim 10, wherein the data input and output buffers have a width of  $n$  bits and wherein the data width of the data buffers are selectively controlled to be  $n$  bits or less.

16. (Currently Amended) The device of claim 10 ~~41~~, wherein the decoder comprises: a switching circuit; and

a logic circuit, wherein the switching circuit is response to the read or write command signal to pass the one or more address bits of the external address signal to the logic circuit and wherein the logic circuit processes the external command to generate the first control signal based on the external command.

17. (Previously Presented) The device of claim 16, wherein the logic circuit comprises a plurality of parallel connected AND gates that receive the one or more address bits of the external address signal, and wherein the first control signal comprises a plural bit signal comprised of the output signals from the AND gates.

18. (Original) The device of claim 17, wherein the data input buffer controller comprises: a switching circuit comprising a plurality of parallel connected switches, wherein each switch receives the write command signal, and wherein one or more switches are selectively activated in response to the first control signal to generate the second control signal, the second control signal comprising a plural bit signal comprised of the output signals of the switches.

19. (Original) The device of claim 17, wherein the data output buffer controller comprises:

a switching circuit comprising a plurality of parallel connected switches, wherein each switch receives the read command signal, and wherein one or more switches are selectively activated in response to the first control signal to generate the second control signal, the second control signal comprising a plural bit signal comprised of the output signals of the switches.

20. (Previously Presented) An integrated circuit (IC) memory device, comprising:  
a memory data buffer; and  
a data width control circuit for selectively varying a data width of the memory data buffer in response to an external control signal applied to one or more address pins of the IC memory device.

21. (Previously Presented) A memory system, comprising:

a controller for generating data access command signals and address signals; and  
a semiconductor integrated circuit (IC) memory chip comprising:  
a plurality of address pins;  
a memory cell array;  
a data buffer for processing data read from or written to the memory cell array;  
and

a data width control circuit for selectively controlling a data width of the data buffer in response to one or more address bits of an external address signal applied to one or more of the address pins of the IC memory chip.

22. (Original) The system of claim 21, wherein the controller is a microprocessor unit.

23. (Original) The system of claim 21, wherein the controller is a network control unit.

24. (Original) The system of claim 21, wherein the controller is a memory controller.

25. (Previously Presented) A method for providing data I/O (input/output) width control in a semiconductor integrated circuit (IC) memory chip, comprising the steps of:

generating a data width control signal in response to one or more address bits of an external address signal applied to one or more address pins of the IC memory chip; and

controlling a data width of a memory data buffer in response to the data width control signal to selectively vary a data width of the memory data buffer.

26. (Previously Presented) A semiconductor memory device, comprising:

an integrated circuit (IC) memory chip comprising an integrated memory circuit and a plurality of address pins, wherein the integrated memory circuit comprises;

a memory cell array;

a data buffer for processing data read from or written to the memory cell array by a read command or write command; and

a data width control circuit for selectively controlling a data width of the data buffer in response to one or more address bits of an external address signal that is accompanied with the read command or write command, and which is applied to one or more of the address pins of the IC memory chip.

27. (Previously Presented) A semiconductor memory device, comprising:

an integrated circuit (IC) memory chip comprising an integrated memory circuit and a plurality of address pins, wherein the integrated memory circuit comprises;

a memory cell array;  
a data buffer for processing data read from or written to the memory cell array by a read command or write command; and  
a data width control circuit for selectively controlling a data width of the data buffer in response to a one or more address bits of a redundant external address signal that is accompanied with the read command or write command, and which is applied to one or more of the address pins of the IC memory chip.